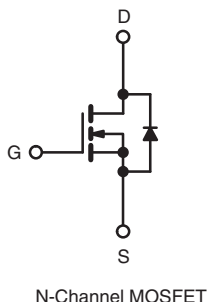
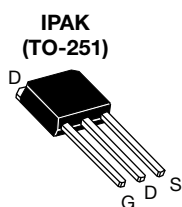


## D Series Power MOSFET

### PRODUCT SUMMARY

|                                         |                 |     |
|-----------------------------------------|-----------------|-----|
| $V_{DS}$ (V) at $T_J$ max.              | 550             |     |
| $R_{DS(on)}$ max. at 25 °C ( $\Omega$ ) | $V_{GS} = 10$ V | 1.5 |
| $Q_g$ (max.) (nC)                       | 20              |     |
| $Q_{gs}$ (nC)                           | 3               |     |
| $Q_{gd}$ (nC)                           | 5               |     |
| Configuration                           | Single          |     |



### FEATURES

- Optimal Design
  - Low Area Specific On-Resistance
  - Low Input Capacitance ( $C_{iss}$ )
  - Reduced Capacitive Switching Losses
  - High Body Diode Ruggedness
  - Avalanche Energy Rated (UIS)
- Optimal Efficiency and Operation
  - Low Cost
  - Simple Gate Drive Circuitry
  - Low Figure-of-Merit (FOM):  $R_{on} \times Q_g$
  - Fast Switching
- Material categorization: For definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)

### APPLICATIONS

- Consumer Electronics
  - Displays (LCD or Plasma TV)
- Server and Telecom Power Supplies
  - SMPS
- Industrial
  - Welding
  - Induction Heating
  - Motor Drives
- Battery Chargers



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**  
Available

### ORDERING INFORMATION

|                                 |               |
|---------------------------------|---------------|
| Package                         | IPAK (TO-251) |
| Lead (Pb)-free                  | SiHU5N50D-E3  |
| Lead (Pb)-free and Halogen-free | SiHU5N50D-GE3 |

### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25$ °C, unless otherwise noted)

| PARAMETER                                                 | SYMBOL         | LIMIT         | UNIT |
|-----------------------------------------------------------|----------------|---------------|------|
| Drain-Source Voltage                                      | $V_{DS}$       | 500           | V    |
| Gate-Source Voltage                                       | $V_{GS}$       | $\pm 30$      |      |
| Gate-Source Voltage AC ( $f > 1$ Hz)                      |                | 30            |      |
| Continuous Drain Current ( $T_J = 150$ °C)                | $I_D$          | 5.3           | A    |
| $V_{GS}$ at 10 V                                          |                | 3.4           |      |
| Pulsed Drain Current <sup>a</sup>                         | $I_{DM}$       | 10            |      |
| Linear Derating Factor                                    |                | 0.83          | W/°C |
| Single Pulse Avalanche Energy <sup>b</sup>                | $E_{AS}$       | 23            | mJ   |
| Maximum Power Dissipation                                 | $P_D$          | 104           | W    |
| Operating Junction and Storage Temperature Range          | $T_J, T_{stg}$ | - 55 to + 150 | °C   |
| Drain-Source Voltage Slope                                | $dV/dt$        | 24            | V/ns |
| Reverse Diode $dV/dt$ <sup>(d)</sup>                      |                | 0.28          |      |
| Soldering Recommendations (Peak Temperature) <sup>c</sup> |                | 300           | °C   |

#### Notes

- Repetitive rating; pulse width limited by maximum junction temperature.
- $V_{DD} = 50$  V, starting  $T_J = 25$  °C,  $L = 2.3$  mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 4.5$  A.
- 1.6 mm from case.
- $I_{SD} \leq I_D$ , starting  $T_J = 25$  °C.

**THERMAL RESISTANCE RATINGS**

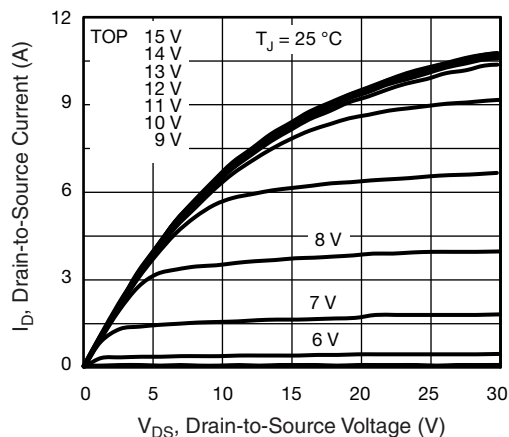
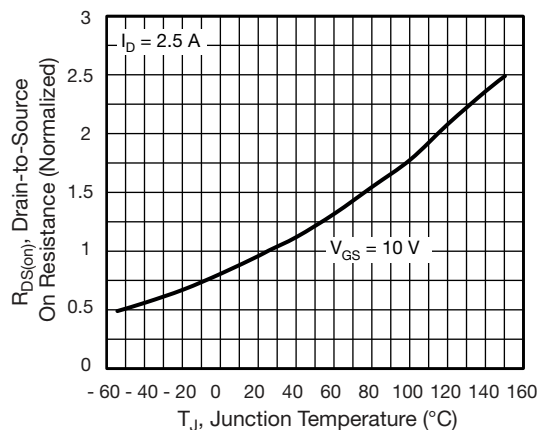
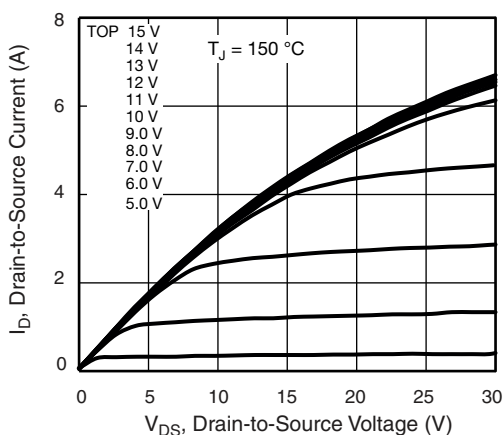
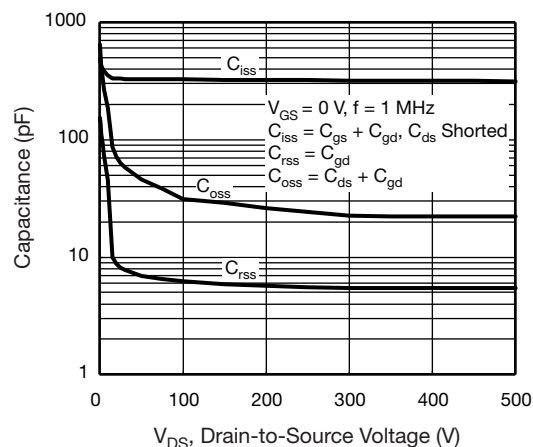
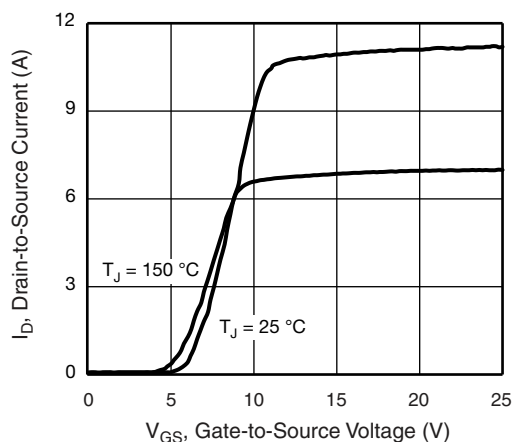
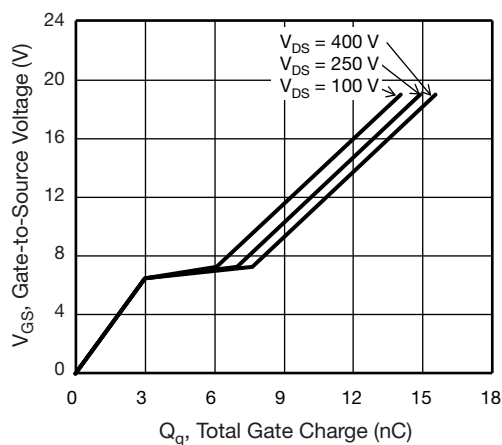
| PARAMETER                        | SYMBOL     | TYP. | MAX. | UNIT |
|----------------------------------|------------|------|------|------|
| Maximum Junction-to-Ambient      | $R_{thJA}$ | -    | 62   | °C/W |
| Maximum Junction-to-Case (Drain) | $R_{thJC}$ | -    | 1.2  |      |

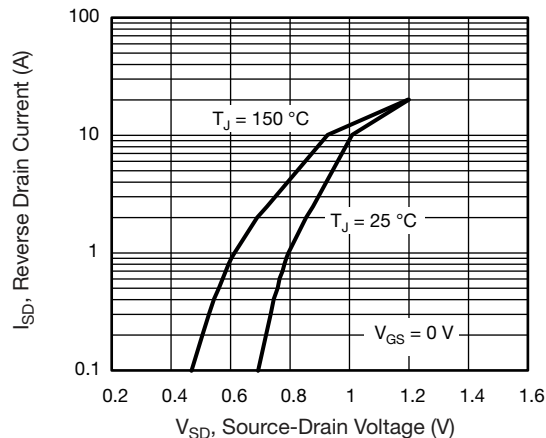
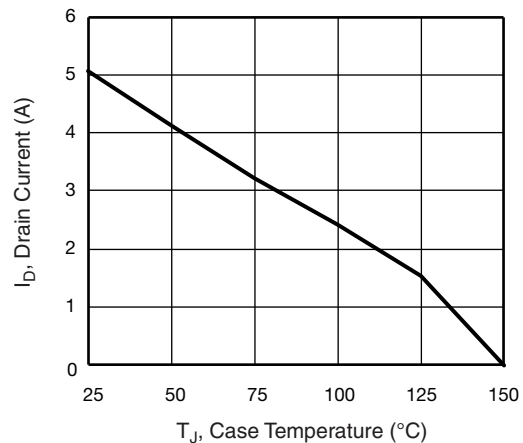
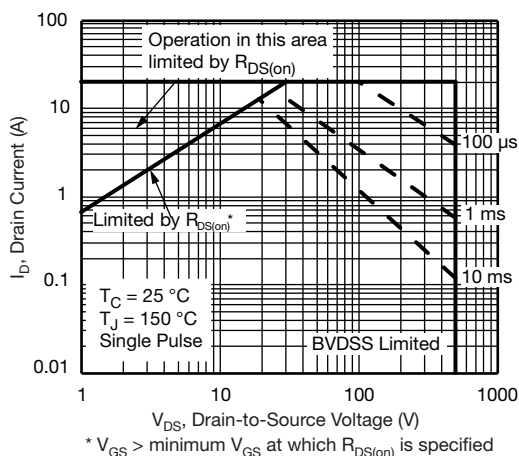
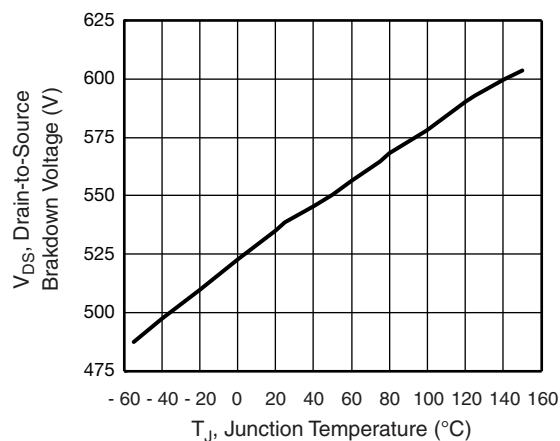
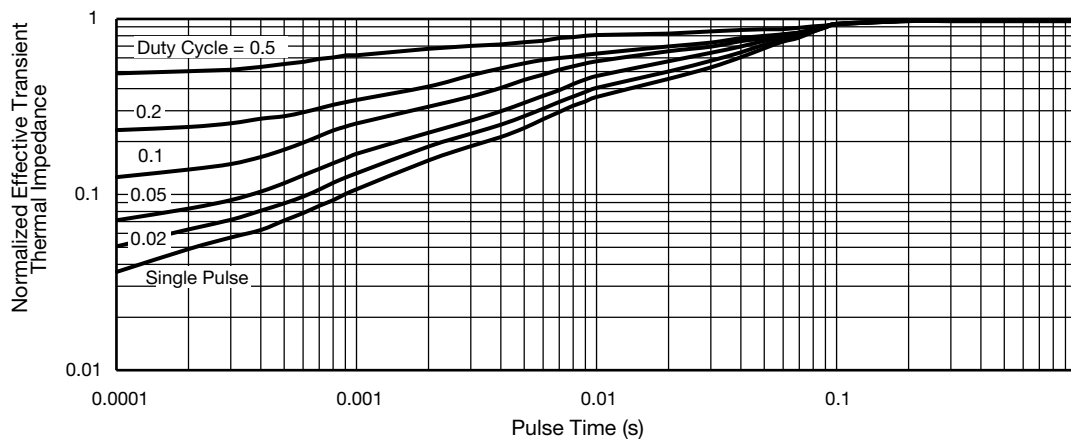
**SPECIFICATIONS** ( $T_J = 25^\circ\text{C}$ , unless otherwise noted)

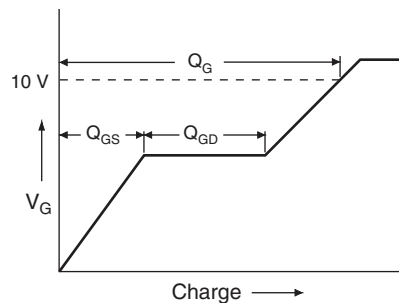
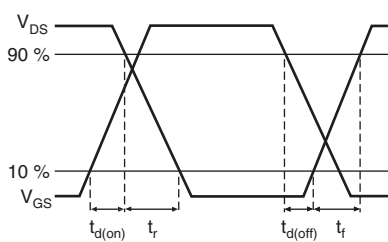
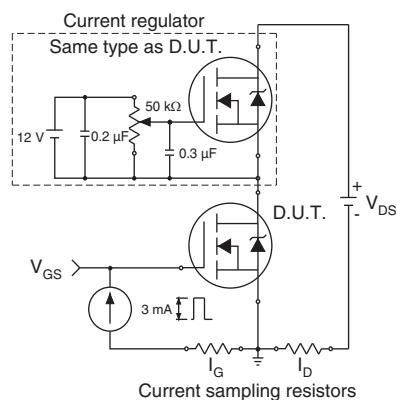
| PARAMETER                                                 | SYMBOL              | TEST CONDITIONS                                                                                                                                       | MIN. | TYP. | MAX.      | UNIT          |
|-----------------------------------------------------------|---------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|-----------|---------------|
| <b>Static</b>                                             |                     |                                                                                                                                                       |      |      |           |               |
| Drain-Source Breakdown Voltage                            | $V_{DS}$            | $V_{GS} = 0\text{ V}$ , $I_D = 250\text{ }\mu\text{A}$                                                                                                | 500  | -    | -         | V             |
| $V_{DS}$ Temperature Coefficient                          | $\Delta V_{DS}/T_J$ | Reference to $25^\circ\text{C}$ , $I_D = 250\text{ }\mu\text{A}$                                                                                      | -    | 0.58 | -         | V/°C          |
| Gate-Source Threshold Voltage (N)                         | $V_{GS(th)}$        | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$                                                                                                    | 3    | -    | 5         | V             |
| Gate-Source Leakage                                       | $I_{GSS}$           | $V_{GS} = \pm 30\text{ V}$                                                                                                                            | -    | -    | $\pm 100$ | nA            |
| Zero Gate Voltage Drain Current                           | $I_{DSS}$           | $V_{DS} = 500\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                                                       | -    | -    | 1         | $\mu\text{A}$ |
|                                                           |                     | $V_{DS} = 400\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 125^\circ\text{C}$                                                                           | -    | -    | 10        |               |
| Drain-Source On-State Resistance                          | $R_{DS(on)}$        | $V_{GS} = 10\text{ V}$ , $I_D = 2.5\text{ A}$                                                                                                         | -    | 1.2  | 1.5       | $\Omega$      |
| Forward Transconductance <sup>a</sup>                     | $g_{fs}$            | $V_{DS} = 20\text{ V}$ , $I_D = 2.5\text{ A}$                                                                                                         | -    | 1.8  | -         | S             |
| <b>Dynamic</b>                                            |                     |                                                                                                                                                       |      |      |           |               |
| Input Capacitance                                         | $C_{iss}$           | $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = 100\text{ V}$ ,<br>$f = 1\text{ MHz}$                                                                            | -    | 325  | -         | pF            |
| Output Capacitance                                        | $C_{oss}$           |                                                                                                                                                       | -    | 34   | -         |               |
| Reverse Transfer Capacitance                              | $C_{rss}$           |                                                                                                                                                       | -    | 6    | -         |               |
| Effective Output Capacitance, Energy Related <sup>b</sup> | $C_{o(er)}$         | $V_{DS} = 0\text{ V to } 400\text{ V}$ , $V_{GS} = 0\text{ V}$                                                                                        | -    | 31   | -         |               |
| Effective Output Capacitance, Time Related <sup>c</sup>   | $C_{o(tr)}$         |                                                                                                                                                       | -    | 41   | -         |               |
| Total Gate Charge                                         | $Q_g$               | $V_{GS} = 10\text{ V}$ ,<br>$I_D = 2.5\text{ A}$ , $V_{DS} = 400\text{ V}$                                                                            | -    | 10   | 20        | nC            |
| Gate-Source Charge                                        | $Q_{gs}$            |                                                                                                                                                       | -    | 3    | -         |               |
| Gate-Drain Charge                                         | $Q_{gd}$            |                                                                                                                                                       | -    | 5    | -         |               |
| Turn-On Delay Time                                        | $t_{d(on)}$         | $V_{DD} = 400\text{ V}$ , $I_D = 2.5\text{ A}$ ,<br>$R_g = 9.1\text{ }\Omega$ , $V_{GS} = 10\text{ V}$                                                | -    | 12   | 24        | ns            |
| Rise Time                                                 | $t_r$               |                                                                                                                                                       | -    | 11   | 22        |               |
| Turn-Off Delay Time                                       | $t_{d(off)}$        |                                                                                                                                                       | -    | 14   | 28        |               |
| Fall Time                                                 | $t_f$               |                                                                                                                                                       | -    | 11   | 22        |               |
| Gate Input Resistance                                     | $R_g$               | $f = 1\text{ MHz}$ , open drain                                                                                                                       | -    | 1.7  | -         | $\Omega$      |
| <b>Drain-Source Body Diode Characteristics</b>            |                     |                                                                                                                                                       |      |      |           |               |
| Continuous Source-Drain Diode Current                     | $I_S$               | MOSFET symbol showing the integral reverse P - N junction diode  | -    | -    | 5         | A             |
| Pulsed Diode Forward Current                              | $I_{SM}$            |                                                                                                                                                       | -    | -    | 20        |               |
| Diode Forward Voltage                                     | $V_{SD}$            | $T_J = 25^\circ\text{C}$ , $I_S = 4\text{ A}$ , $V_{GS} = 0\text{ V}$                                                                                 | -    | -    | 1.2       | V             |
| Reverse Recovery Time                                     | $t_{rr}$            | $T_J = 25^\circ\text{C}$ , $I_F = I_S = 2.5\text{ A}$ ,<br>$di/dt = 100\text{ A}/\mu\text{s}$ , $V_R = 20\text{ V}$                                   | -    | 320  | -         | ns            |
| Reverse Recovery Charge                                   | $Q_{rr}$            |                                                                                                                                                       | -    | 1.2  | -         | $\mu\text{C}$ |
| Reverse Recovery Current                                  | $I_{RRM}$           |                                                                                                                                                       | -    | 8    | -         | A             |

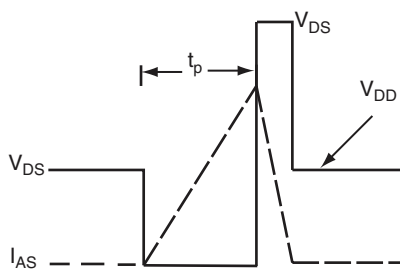
**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature.  
b.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .  
c.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Fig. 1 - Typical Output Characteristics**

**Fig. 4 - Normalized On-Resistance vs. Temperature**

**Fig. 2 - Typical Output Characteristics**

**Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage**


**Fig. 7 - Typical Source-Drain Diode Forward Voltage**

**Fig. 9 - Maximum Drain Current vs. Case Temperature**

**Fig. 8 - Maximum Safe Operating Area**

**Fig. 10 - Typical Drain-to-Source Voltage vs. Temperature**

**Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case**


**Fig. 12 - Switching Time Test Circuit**

**Fig. 16 - Basic Gate Charge Waveform**

**Fig. 13 - Switching Time Waveforms**

**Fig. 17 - Gate Charge Test Circuit**

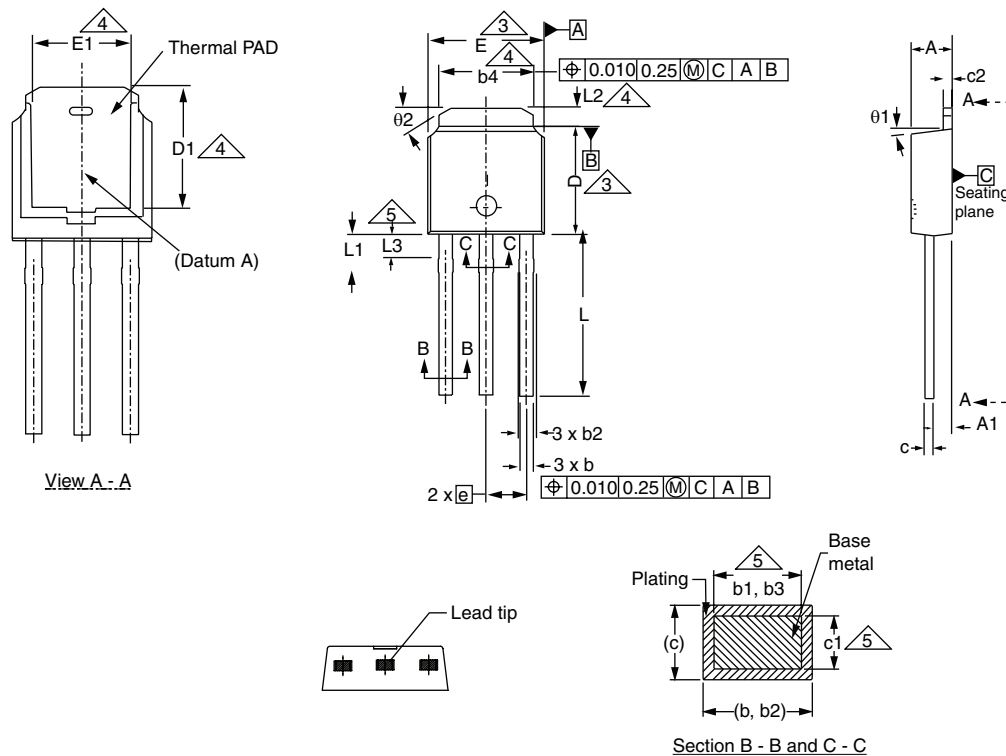
**Fig. 14 - Unclamped Inductive Test Circuit**

**Fig. 15 - Unclamped Inductive Waveforms**



**Fig. 18 - For N-Channel**

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## TO-251AA (HIGH VOLTAGE)



| DIM. | MILLIMETERS |      | INCHES |       |
|------|-------------|------|--------|-------|
|      | MIN.        | MAX. | MIN.   | MAX.  |
| A    | 2.18        | 2.39 | 0.086  | 0.094 |
| A1   | 0.89        | 1.14 | 0.035  | 0.045 |
| b    | 0.64        | 0.89 | 0.025  | 0.035 |
| b1   | 0.65        | 0.79 | 0.026  | 0.031 |
| b2   | 0.76        | 1.14 | 0.030  | 0.045 |
| b3   | 0.76        | 1.04 | 0.030  | 0.041 |
| b4   | 4.95        | 5.46 | 0.195  | 0.215 |
| c    | 0.46        | 0.61 | 0.018  | 0.024 |
| c1   | 0.41        | 0.56 | 0.016  | 0.022 |
| c2   | 0.46        | 0.86 | 0.018  | 0.034 |
| D    | 5.97        | 6.22 | 0.235  | 0.245 |

| DIM. | MILLIMETERS |      | INCHES   |       |
|------|-------------|------|----------|-------|
|      | MIN.        | MAX. | MIN.     | MAX.  |
| D1   | 5.21        | -    | 0.205    | -     |
| E    | 6.35        | 6.73 | 0.250    | 0.265 |
| E1   | 4.32        | -    | 0.170    | -     |
| e    | 2.29 BSC    |      | 2.29 BSC |       |
| L    | 8.89        | 9.65 | 0.350    | 0.380 |
| L1   | 1.91        | 2.29 | 0.075    | 0.090 |
| L2   | 0.89        | 1.27 | 0.035    | 0.050 |
| L3   | 1.14        | 1.52 | 0.045    | 0.060 |
| θ1   | 0°          | 15°  | 0°       | 15°   |
| θ2   | 25°         | 35°  | 25°      | 35°   |

ECN: S-82111-Rev. A, 15-Sep-08  
DWG: 5968

### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.
2. Dimension are shown in inches and millimeters.
3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.13 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
4. Thermal pad contour optional with dimensions b4, L2, E1 and D1.
5. Lead dimension uncontrolled in L3.
6. Dimension b1, b3 and c1 apply to base metal only.
7. Outline conforms to JEDEC outline TO-251AA.



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Электрон  
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Благодаря сотрудничеству с мировыми поставщиками мы осуществляем комплексные и плановые поставки широчайшего спектра электронных компонентов.

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**Электронная почта:** [sales@st-electron.ru](mailto:sales@st-electron.ru)

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